

MRT Technology (Taiwan) Co., Ltd

Phone: +886-3-3288388
Fax: +886-3-3288918
Web: <u>www.mrt-cert.com</u>

Report No.: 2406TW3801-U2 Report Version: 1.0 Issue Date: 2024-08-21

# **MEASUREMENT REPORT**

FCC ID : 2A8TK-ANAL1168EX

APPLICANT : G-TECH INSTRUMENTS INC.

**Application Type : Certification** 

Product : Portable Analyzer

Model No. : CMVA 90-EX, CMVA 90, impaq Plus-EX, impaq Plus

Brand Name : G-TECH, SKF, Benstone

FCC Classification: (DXX) Part 15 Low Power Communication Device

**Transmitter** 

FCC Rule Part(s) : Part 15.225

Test Procedure(s): ANSI C63.10-2013

Received Date : June 07, 2024

Test Date : July 11, 2024~ July 16, 2024

Tested By : Kaunaz Lee

(Kaunaz Lee)

Reviewed By : Paddy Chen

(Paddy Chen)

Approved By : any her

(Chenz Ker)





3261

The test results only relate to the tested sample.

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.10. Test results reported herein relate only to the item(s) tested.

The test report shall not be reproduced except in full without the written approval of MRT Technology (Taiwan) Co., Ltd.

Page Number: 1 of 40



# **Revision History**

Report No.	Version	Description	Issue Date	Note
2406TW3801-U2	1.0	Original Report	2024-08-21	

Page Number: 2 of 40



# **CONTENTS**

De	scription	on	Page
1.	INTR	ODUCTION	6
	1.1.	Scope	6
	1.2.	MRT Test Location	6
2.	PRO	DUCT INFORMATION	7
	2.1.	Equipment Description	7
	2.2.	Test Mode	8
	2.3.	Test Software	8
	2.4.	Test Configuration	8
	2.5.	Test System Details	8
	2.6.	EMI Suppression Device(s)/Modifications	9
	2.7.	Labeling Requirements	9
3.	DES	CRIPTION of TEST	10
	3.1.	Evaluation Procedure	10
	3.2.	AC Line Conducted Emissions	10
	3.3.	Radiated Emissions	11
4.	ANT	ENNA REQUIREMENTS	12
5.	TEST	Γ EQUIPMENT CALIBRATION DATE	13
6.	MEA	SUREMENT UNCERTAINTY	14
7.	TEST	Γ RESULT	15
	7.1.	Summary	15
	7.2.	Field Strength of Fundamental Emissions Measurement	
	7.2.1.	Test Limit	16
	7.2.2.	Test Procedure used	16
	7.2.3.	Test Setup	17
	7.2.4.	Test Result	18
	7.3.	Radiated Spurious Emissions Measurement	20
	7.3.1.	Test Limit	20
	7.3.2.	Test Procedure Used	20
	7.3.3.	Test Setup	22
	7.3.4.	Test Result	23
	7.4.	20dB Bandwidth Measurement	29
	7.4.1.	Test Limit	29
	7.4.2.	Test Procedure Used	29



	7.4.3.	Test Setting	29
	7.4.4.	Test Setup	29
	7.4.5.	Test Result	30
	7.5.	Frequency Stability Measurement	31
	7.5.1.	Test Limit	31
	7.5.2.	Test Procedure Used	31
	7.5.3.	Test Setup	32
	7.5.4.	Test Result	33
	7.6.	AC Conducted Emissions Measurement	34
	7.6.1.	Test Limit	34
	7.6.2.	Test Setup	34
	7.6.3.	Test Result	35
8.	CONC	CLUSION	39
Аp	pendix .	A : Test Photograph	40
Ар	pendix	B : External Photograph	40
Αn	pendix	C : Internal Photograph	40



# **General Information**

Applicant	G-TECH INSTRUMENTS INC.		
Applicant Address	2F2, No. 83, Sec. 2, Gongdao 5th Rd., East Dist., Hsinchu City 30070, Taiwan (R.O.C.)		
Manufacturer	G-TECH INSTRUMENTS INC.		
Manufacturer Address	2F2, No. 83, Sec. 2, Gongdao 5th Rd., East Dist., Hsinchu City 30070, Taiwan (R.O.C.)		
Test Site	MRT Technology (Taiwan) Co., Ltd		
Test Site Address	No. 38, Fuxing Second Rd., Guishan Dist., Taoyuan City 333, Taiwan (R.O.C)		
MRT FCC Registration No.	291082		
FCC Rule Part(s)	Part 15.225		
Test Device Serial No.	#1-1 Production Pre-Production Engineering		

# **Test Facility / Accreditations**

- **1.** MRT facility is a FCC registered (Reg. No. 291082) test facility with the site description report on file and is designated by the FCC as an Accredited Test Firm.
- 2. MRT facility is an IC registered (MRT Reg. No. 21723) test laboratory with the site description on file at Industry Canada.
- 3. MRT Lab is accredited to ISO 17025 by the Taiwan Accreditation Foundation (TAF Cert. No. 3261) in EMC, Telecommunications and Radio testing for FCC (Designation Number: TW3261), Industry Canada, EU and TELEC Rules.

Page Number: 5 of 40



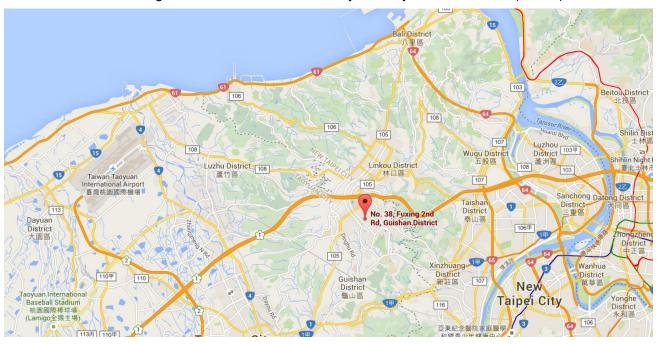
# 1. INTRODUCTION

# 1.1. Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

# 1.2. MRT Test Location

The map below shows the location of the MRT LABORATORY, its proximity to the Taoyuan City. These measurement tests were conducted at the MRT Technology (Taiwan) Co., Ltd. Facility located at No.38, Fuxing 2nd Rd., Guishan Dist., Taoyuan City 33377, Taiwan (R.O.C).





# 2. PRODUCT INFORMATION

# 2.1. Equipment Description

Product Name	Portable Analyzer			
Brand Name	G-TECH, SKF, Benstone			
Model Number	CMVA 90-EX, CMVA 90, impaq Plus-EX, impaq Plus			
RFID Specification	13.56MHz			
Modulation	ASK			
Antenna Type	PCB Antenna			
Accessory				
	Brand: FSP GROUP INC.			
	Model No: FSP060-DHAN3			
Power Adapter	Input: AC 100-240V~1.8A, 50-60Hz			
	Output: DC 12V, 5A 60.0W			
	Cable Out: Non-shielding, 1.2m with Core*1			

Note: Model Difference can refer as below, the other hardware was the same. (declared by the manufacturer)

Model	Brand Name			
impaq Plus-EX, impaq Plus	G-TECH			
CMVA 90-EX, CMVA 90	SKF			
impaq Plus-EX, impaq Plus	Benstone			
The test was performed base on CMVA 90-EX				

Page Number: 7 of 40



# 2.2. Test Mode

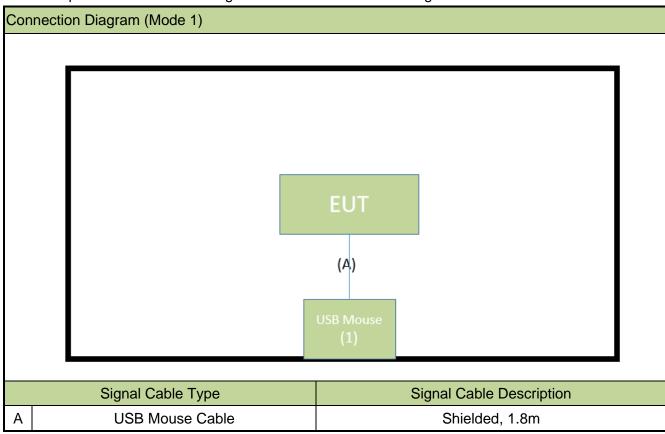
Test Mode	Mode 1: Transmit by RFID

# 2.3. Test Software

N/A.

# 2.4. Test Configuration

The **Portable Analyzer**, ANSI C63.10-2013 was used to reference the appropriate EUT setup for radiated spurious emissions testing and AC line conducted testing.



# 2.5. Test System Details

The types for all equipment, and descriptions of all cables used in the tested system (including inserted cards) are:

	Product	Manufacturer	Model No.	Serial No.	Power Cord
1	USB Mouse	Logitech	M90	N/A	N/A

Page Number: 8 of 40



# 2.6. EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and/or no modifications were made during testing.

# 2.7. Labeling Requirements

# Per 2.1074 & 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphlet supplied to the user and be readily visible to the purchaser at the time of purchase. However, when the device is so small wherein placement of the label with specified statement is not practical, only the FCC ID must be displayed on the device per Section 15.19(a)(5). Please see attachment for FCC ID label and label location.

Page Number: 9 of 40



# 3. DESCRIPTION of TEST

# 3.1. Evaluation Procedure

# 3.2. AC Line Conducted Emissions

The line-conducted facility is located inside an 9'x4'x3' shielded enclosure. A 1m x 2m wooden table 80cm high is placed 40cm away from the vertical wall and 80cm away from the sidewall of the shielded room. Two 10kHz-30MHz,  $50\Omega/50$ uH Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room floor. Power to the LISNs is filtered by external high-current high-insertion loss power line filters. These filters attenuate ambient signal noise from entering the measurement lines. These filters are also bonded to the shielded enclosure.

The EUT is powered from one LISN and the support equipment is powered from the second LISN. All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion) and draped over the back edge of the test table. All cables were at least 40cm above the horizontal reference ground-plane. Power cables for support equipment were routed down to the second LISN while ensuring that that cables were not draped over the second LISN.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the receiver and exploratory measurements were made to determine the frequencies producing the maximum emission from the EUT. The receiver was scanned from 150kHz to 30MHz. The detector function was set to peak mode for exploratory measurements while the bandwidth of the analyzer was set to 9kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Each emission was also maximized by varying: power lines, the mode of operation or data exchange speed, or support equipment which determined the worst-case emission. Once the worst case emissions have been identified, the one EUT cable configuration/arrangement and mode of operation that produced these emissions are used for final measurements on the same test site. The analyzer is set to CISPR quasi-peak and average detectors with a 9kHz resolution bandwidth for final measurements.

An extension cord was used to connect to a single LISN which powered by EUT. The extension cord was calibrated with LISN, the impedance and insertion loss are compliance with the requirements as stated in ANSI C63.10-2013.

Line conducted emissions test results are shown in Section 7.6.



# 3.3. Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. A MF Model 210SS turntable is used for radiated measurement. It is a continuously rotatable, remote controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm high PVC support structure is placed on top of the turntable. For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up for frequencies below 1GHz was placed on top of the 0.8 meter high, 1 x 1.5 meter table; and test set-up for frequencies 1-40GHz was placed on top of the 1.5 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, which produced the worst-case emissions. According to 3dB Beam-Width of horn antenna, the horn antenna should be always directed to the EUT when rising height.

Radiated Emissions test results are shown in Section 7.2 & 7.3.



# 4. ANTENNA REQUIREMENTS

# Excerpt from §15.203 of the FCC Rules/Regulations:

"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antenna of Portable Analyzer is permanently attached.
- There are no provisions for connection to an external antenna.

# **Conclusion:**

The Portable Analyzer unit complies with the requirement of §15.203.

Page Number: 12 of 40



# 5. TEST EQUIPMENT CALIBRATION DATE

# Conducted Emissions – SR2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Two-Line V-Network	R&S	ENV216	MRTTWA00019	1 year	2025/3/5
Cable	Rosnol	N1C50-RG400-B 1C50-500CM	MRTTWE00013	1 year	2025/6/14
EMI Test Receiver	R&S	ESR3	MRTTWA00009	1 year	2025/3/5

# Radiated Emissions - AC1

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Acitve Loop Antenna	SCHWARZBECK	FMZB 1519B	MRTTWA00002	1 year	2025/5/7
Broadband TRILOG Antenna	SCHWARZBECK	VULB 9162	MRTTWA00001	1 year	2024/10/31
Broadband Hornantenna	SCHWARZBECK	BBHA 9120D	MRTTWA00003	1 year	2025/2/28
Broadband Preamplifier	SCHWARZBECK	BBV 9718	MRTTWA00005	1 year	2025/2/28
Breitband Hornantenna	SCHWARZBECK	BBHA 9170	MRTTWA00004	1 year	2025/3/26
Broadband Amplifier	SCHWARZBECK	BBV 9721	MRTTWA00006	1 year	2025/3/21
EMI Test Receiver	R&S	ESR3	MRTTWA00009	1 year	2025/3/5
Signal Analyzer	R&S	FSV40	MRTTWA00007	1 year	2025/3/14
Antenna Cable	HUBERSUHNER	SF106	MRTTWE00010	1 year	2025/6/14
Cable	Rosnol	K1K50-UP0264- K1K50-4M	MRTTWE00012	1 year	2025/6/14
Temperature/Humidity Meter	TFA	35.1083	MRTTWA00050	1 year	2025/6/2

# Conducted Test Equipment - SR6

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EXA Signal Analyzer	KEYSIGHT	N9010A	MRTTWA00012	1 year	2024/10/17
EXA Signal Analyzer	KEYSIGHT	N9010B	MRTTWA00074	1 year	2024/8/19
USB Wideband Power Sensor	KEYSIGHT	U2021XA	MRTTWA00015	1 year	2025/3/12

# **Test Software**

Software	Version	Function
e3	9.160520a	EMI Test Software
ЕМІ	V3	EMI Test Software

Page Number: 13 of 40



# 6. MEASUREMENT UNCERTAINTY

Where relevant, the following test uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k = 2.

# Conducted Emission- Power Line

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

0.15MHz~30MHz: ± 2.53dB

# **Conducted Measurement**

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)): ±1.3dB

# Radiated Spurious Emission

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

9kHz~30MHz: ± 3.92dB 30MHz~1GHz: ± 4.25dB 1GHz~18GHz: ± 4.40dB 18GHz~40GHz: ± 4.45dB



# 7. TEST RESULT

# 7.1. Summary

Product Name: Portable Analyzer

FCC Classification: (DXX) Part 15 Low Power Communication Device Transmitter

FCC Part Section(s)	Test Description	ion Test Limit		Test Result	Reference
15.225 (a)(b)(c)	Field Strength of Fundamental Emissions	FCC 15.225 limits	Dodiotod	Pass	Section 7.2
15.225(d)	Radiated Spurious Emissions	FCC 15.209 limits	Radiated	Pass	Section 7.3
2.1049	20dB Bandwidth	N/A		Pass	Section 7.4
15.225(e)	Frequency Stability	within ±0.01% of the operating frequency	Conducted	Pass	Section 7.5
15.207	AC Conducted Emissions 150kHz - 30MHz	FCC 15.207 limits	Line Conducted	Pass	Section 7.6

- Determining compliance is based on the test results met the regulation limits or requirements declared by clients, and the test results don't take into account the value of measurement uncertainty.
- 2) All modes of operation and data rates were investigated. For radiated emission test, every axis (X, Y, Z) was also verified. The test results shown in the following sections represent the worst case emissions.
- 3) The analyzer plots shown in this section were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables and attenuators used as part of the system to connect the EUT to the analyzer at all frequencies of interest.
- 4) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables and attenuators.



# 7.2. Field Strength of Fundamental Emissions Measurement

# 7.2.1. Test Limit

FCC Part 15.225 Limits							
Frequency	Field Strength	Field Strength	Field Strength	Field Strength			
(MHz)	(µV/m) at 30m	(dBµV/m) at 30m	(dBµV/m) at 10m	(dBµV/m) at 3m			
1.705 – 13.110	30	29.5	48.58	69.5			
13.110 – 13.410	106	40.5	59.98	80.5			
13.410 – 13.553	334	50.5	69.58	90.5			
13.553 – 13.567	15848	84	103.08	124			
13.567 – 13.710	334	50.5	69.58	90.5			
13.710 – 14.010	106	40.5	59.98	80.5			
14.010 – 30.000	30	29.5	48.58	69.5			

Note: Measurements were tested at 3m and the data was extrapolated to the specified measurement distance of 30m using the square of an inverse linear extrapolation factor (40 dB/decade) as specified in &15.31(f)(2).

### 7.2.2. Test Procedure used

(A) ANSI C63.10-2013 - Section 11.12.2.3 (quasi-peak measurements)

The specifications for measurements using the CISPR quasi-peak detector can be found in CISPR 16-1-1, As an alternative to CISPR quasi-peak measurement, compliance can be determined for the applicable emission requirements using a peak detector.

(B) ANSI C63.10-2013 - Section 11.12.2.4 (peak power measurements)

- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. RBW = as specified in Table 1
- 3. VBW ≥ 3 × RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- 7. Allow the trace was allowed to stabilize

Page Number: 16 of 40

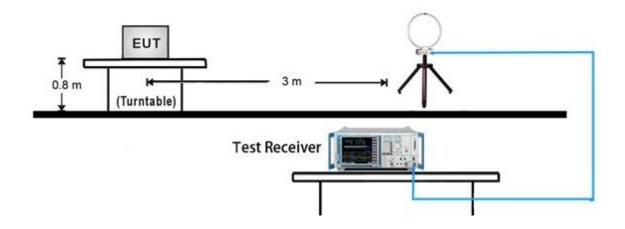


Table 1 - RBW as a function of frequency

Frequency	RBW		
9 kHz ~ 150 kHz	200 Hz ~ 300 Hz		
0.15 MHz ~ 30 MHz	9 kHz ~ 10 kHz		

# 7.2.3. Test Setup

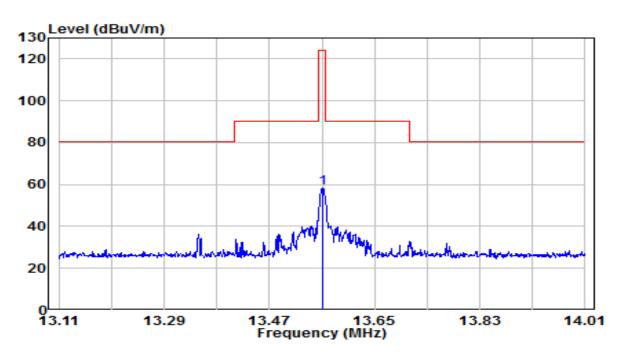
# 9kHz ~ 30MHz Test Setup:





# 7.2.4. Test Result

EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	FMZB 1519B	Temp. / Humidity	22°C /57%
Polarity	Face On	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz

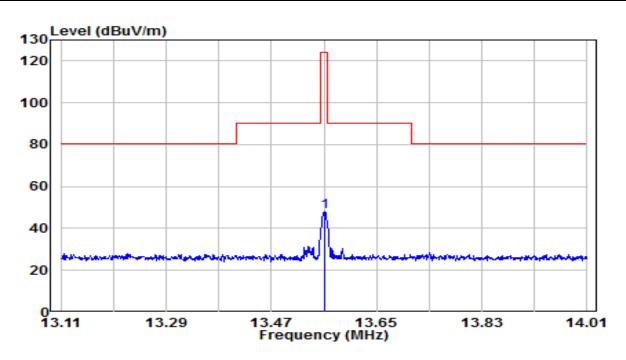


No		Frequency	Reading	C.F	Measurement	Margin	Limit	Height	Angle	Remark
No		(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dB)	(dBuV/m)	(cm)	(deg)	(QP/PK/AV)
1	*	13.561	36.93	21.46	58.39	-65.61	124.00	100	360	Peak

- 1. "  $^*$ ", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.



EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	FMZB 1519B	Temp. / Humidity	22°C /57%
Polarity	Face Off	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz



NI		Frequency	Reading	C.F	Measurement	Margin	Limit	Height	Angle	Remark
INC	No	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dB)	(dBuV/m)	(cm)	(deg)	(QP/PK/AV)
1	*	13.562	26.65	21.46	48.11	-75.89	124.00	100	360	Peak

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.



# 7.3. Radiated Spurious Emissions Measurement

# 7.3.1. Test Limit

All out of band emissions appearing in a restricted band as specified in Section 15.225 of the Title 47 CFR must not exceed the limits shown in Table per Section 15.209.

FCC Part 15 Subpart C Paragraph 15.209								
Frequency [MHz]	Field Strength [V/m]	Measured Distance [Meters]						
0.009 - 0.490	2400/F (kHz)	300						
0.490 - 1.705	24000/F (kHz)	30						
1.705 - 30	30	30						
30 - 88	100	3						
88 - 216	150	3						
216 - 960	200	3						
Above 960	500	3						

Note: The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90 kHz, 110-490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.

# 7.3.2. Test Procedure Used

(A) ANSI C63.10-2013 - Section 11.12.2.3 (quasi-peak measurements)

The specifications for measurements using the CISPR quasi-peak detector can be found in CISPR 16-1-1. As an alternative to CISPR quasi-peak measurement, compliance can be determined for the applicable emission requirements using a peak detector.

Page Number: 20 of 40



- (B) ANSI C63.10-2013 Section 11.12.2.4 (peak power measurements)
- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2.RBW = as specified in Table 1
- $3.VBW = 3 \times RBW$
- 4. Detector = peak
- 5. Sweep time = auto couple

Table 1 - RBW as a function of frequency

Frequency	RBW
9 kHz ~ 150 kHz	200 Hz ~ 300 Hz
0.15 MHz ~ 30 MHz	9 kHz ~ 10 kHz
30 MHz ~ 1000 MHz	100 kHz ~ 120 kHz
> 1000 MHz	1 MHz

- (C) ANSI C63.10-2013 Section 11.12.2.5 (average power measurements)
- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. RBW = 1MHz
- 3. VBW ≥ 1/T
- 4. Video bandwidth mode or display mode:
  - 1) The instrument shall be set to ensure that video filtering is applied in the power domain.

    Typically, this requires setting the detector mode to RMS (power averaging) and setting the average-VBW type to power (rms).
  - 2) As an alternative, the instrument may be set to linear detector mode. Ensure that video filtering is applied in linear voltage domain (rather than in a log or dB domain). Some instruments require linear display mode to accomplish this. Others have a setting for average-VBW type, which can be set to "voltage" regardless of the display mode. Detector =

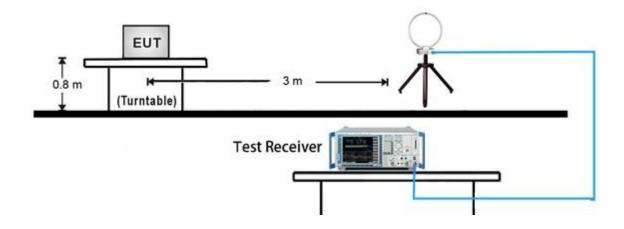


Peak

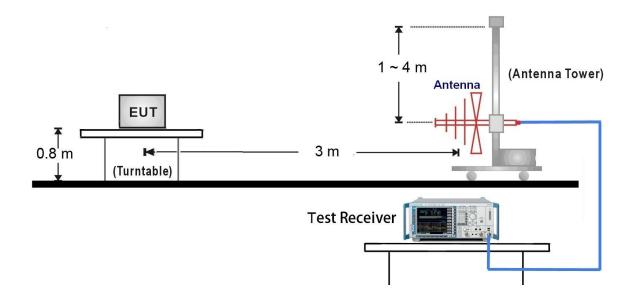
- 5. Sweep time = auto
- 6. Trace mode = max hold
- 7. Allow max hold to run for at least 50 times (1/duty cycle) traces

# 7.3.3. Test Setup

9kHz ~ 30MHz Test Setup:



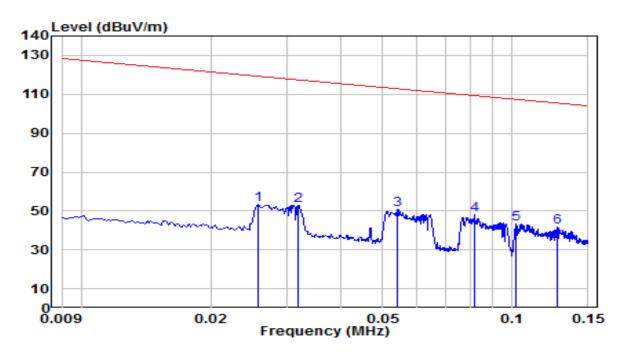
# 30MHz ~ 1GHz Test Setup:





# 7.3.4. Test Result

EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	FMZB 1519B	Temp. / Humidity	22°C /57%
Polarity	Face On	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz

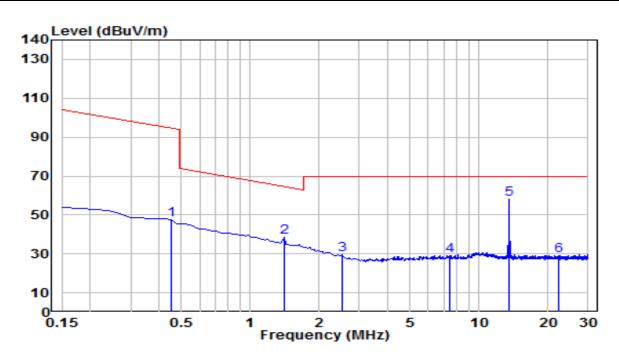


No	Frequency (MHz)	Reading (dBuV)	C.F (dB/m)	Measurement (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Height (cm)	Angle (deg)	Remark (QP/PK/AV)
1	0.026	33.80	19.40	53.21	-66.16	119.37	100	179	Peak
2	0.032	33.47	19.58	53.05	-64.48	117.53	100	187	Peak
3	0.054	31.85	18.95	50.80	-62.10	112.91	100	341	Peak
4	* 0.082	29.61	18.40	48.02	-61.33	109.35	100	341	Peak
5	0.102	25.16	18.05	43.21	-64.20	107.41	100	200	Peak
6	0.128	23.37	18.11	41.48	-64.00	105.49	100	196	Peak

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.



EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	FMZB 1519B	Temp. / Humidity	22°C /57%
Polarity	Face On	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz

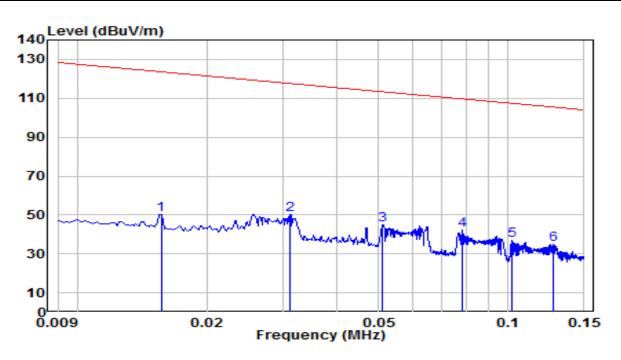


No	Frequency (MHz)	Reading (dBuV)	C.F (dB/m)	Measurement (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Height (cm)	Angle (deg)	Remark (QP/PK/AV)
1	0.449	28.92	18.65	47.57	-46.99	94.57	100	208	Peak
2	* 1.404	19.88	18.62	38.50	-26.18	64.68	100	224	Peak
3	2.508	10.99	18.67	29.65	-39.85	69.50	100	249	Peak
4	7.404	9.18	20.10	29.28	-40.22	69.50	100	247	Peak
5	13.553	36.57	21.46	58.04	N/A	N/A	100	10	Peak
6	22.448	6.79	22.42	29.21	-40.29	69.50	100	174	Peak

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.
- 5. This frequency is 13.553MHz RFID operating frequency.



EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	FMZB 1519B	Temp. / Humidity	22°C /57%
Polarity	Face Off	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz

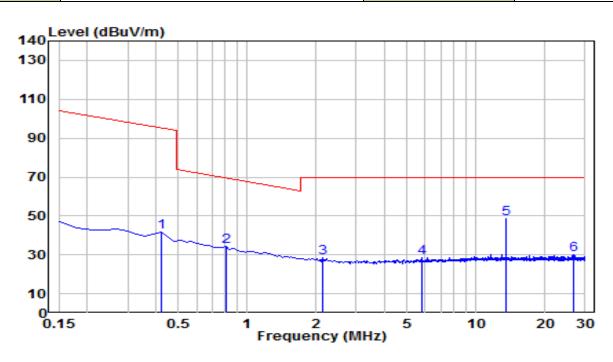


No		Frequency	Reading	C.F	Measurement	Margin	Limit	Height	Angle	Remark
INO		(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dB)	(dBuV/m)	(cm)	(deg)	(QP/PK/AV)
1		0.016	31.46	18.84	50.30	-73.41	123.71	100	130	Peak
2	*	0.031	30.80	19.60	50.40	-67.33	117.73	100	214	Peak
3		0.051	25.69	19.02	44.71	-68.71	113.42	100	214	Peak
4		0.078	23.79	18.48	42.26	-67.48	109.75	100	239	Peak
5		0.102	19.05	18.05	37.10	-70.32	107.42	100	204	Peak
6		0.127	16.79	18.11	34.91	-70.59	105.49	100	196	Peak

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.



EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	FMZB 1519B	Temp. / Humidity	22°C /57%
Polarity	Face Off	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz

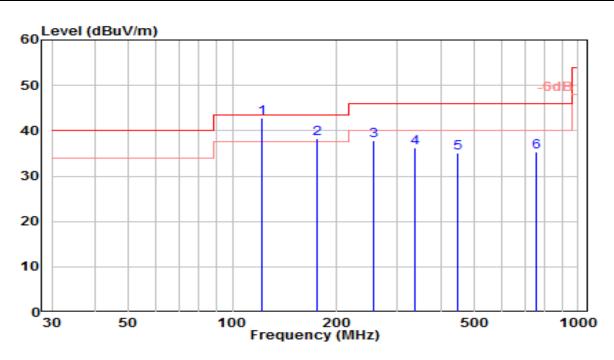


No	Frequency Reading C.F		Measurement	Margin	Limit	Height	Angle	Remark	
INO	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dB)	(dBuV/m)	(cm)	(deg)	(QP/PK/AV)
1	0.419	22.92	18.63	41.56	-53.61	95.17	100	208	Peak
2	0.807	15.80	18.63	34.43	-35.05	69.48	100	204	Peak
3	2.150	9.64	18.65	28.29	-41.21	69.50	100	252	Peak
4	5.792	9.17	19.59	28.76	-40.74	69.50	100	0	Peak
5	13.553	27.28	21.46	48.75	N/A	N/A	100	34	Peak
6	* 26.866	7.52	22.43	29.95	-39.55	69.50	100	80	Peak

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.
- 5. This frequency is 13.553MHz RFID operating frequency.



EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	VULB 9162	Temp. / Humidity	22°C /57%
Polarity	Horizontal	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz

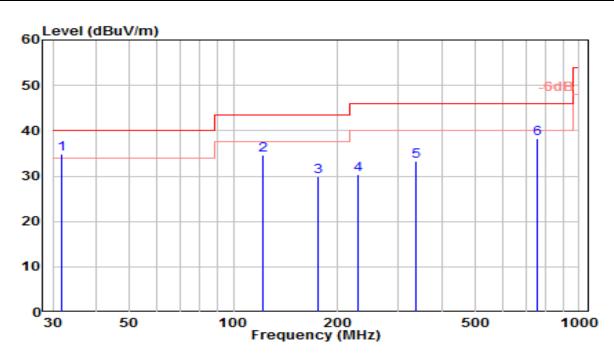


No		Frequency	Reading	C.F	Measurement	Margin	Limit	Height	Angle	Remark
INO		(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dB)	(dBuV/m)	(cm)	(deg)	(QP/PK/AV)
1	*	121.180	26.00	16.80	42.80	-0.70	43.50	150	85	QP
2		175.500	22.09	16.25	38.34	-5.16	43.50	150	60	QP
3		256.980	17.53	20.22	37.75	-8.25	46.00	100	325	QP
4		338.460	13.93	22.23	36.16	-9.84	46.00	100	35	QP
5		447.100	11.13	24.07	35.20	-10.80	46.00	150	335	QP
6		756.530	5.80	29.45	35.24	-10.76	46.00	100	215	QP

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.



EUT	Portable Analyzer	Date of Test	2024-07-11
Factor	VULB 9162	Temp. / Humidity	22°C /57%
Polarity	Vertical	Site / Test Engineer	AC1 / Todd
Test Mode	TX-RFID 13.56MHz	Test Voltage	AC 120V/60Hz



No		Frequency (MHz)	Reading (dBuV)	C.F (dB/m)	Measurement (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Height (cm)	Angle (deg)	Remark (QP/PK/AV)
		(1711 12)	(ubuv)	(ub/III)	(aba v/III)	(ub)	(aba v/III)	(CIII)	(ueg)	(QI/IIVAV)
1	*	31.940	17.85	16.93	34.78	-5.22	40.00	100	230	QP
2		121.180	17.75	16.80	34.54	-8.96	43.50	150	10	QP
3		175.500	13.54	16.25	29.79	-13.71	43.50	150	360	QP
4		229.820	11.09	19.15	30.25	-15.75	46.00	150	15	QP
5		338.460	11.06	22.23	33.30	-12.70	46.00	150	35	QP
6		756.530	8.90	29.45	38.35	-7.65	46.00	150	185	QP

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = Antenna Factor (dB/m) + Cable Loss (dB).
- 3. Measurement (dBuV/m) = Reading(dBuV) + C.F (Correction Factor).
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.



# 7.4. 20dB Bandwidth Measurement

# 7.4.1. Test Limit

N/A

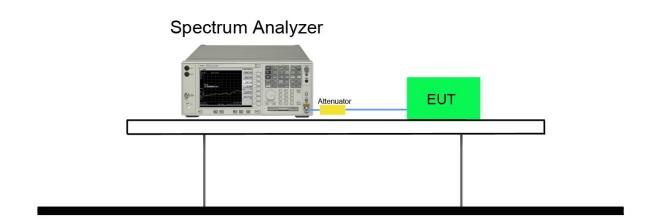
### 7.4.2. Test Procedure Used

KDB 789033 D02v01r01 - Section C.1

# 7.4.3. Test Setting

- 1. The analyzers' automatic bandwidth measurement capability was used to perform the 20dB bandwidth measurement. The "X" dB bandwidth parameter was set to X = 20. The automatic bandwidth measurement function also has the capability of simultaneously measuring the 99% occupied bandwidth. The bandwidth measurement was not influenced by any intermediated power nulls in the fundamental emission.
- 2. RBW = approximately 1% ~5% of the emission bandwidth.
- 3.  $VBW \ge 3 \times RBW$ .
- 4. Detector = Peak.
- 5. Trace mode = max hold.

# 7.4.4. Test Setup





# 7.4.5. Test Result

Test Mode	Frequency	20dB Bandwidth	99% Bandwidth		
	(MHz)	(kHz)	(kHz)		
RFID	13.56	0.2468	0.21278		

# RECEIVER Spectrum Ref sevel 82:80 day/ 8 AH 10 60 SWF 19.1 ms © YBW 300 Hz 8 AH 10 60 SWF 19.1 ms © YBW 300 Hz 8 AH 10 60 SWF 19.1 ms © YBW 300 Hz 8 AH 10 60 SWF 19.1 ms © YBW 300 Hz 8 AH 10 60 SWF 19.1 ms © YBW 300 Hz 8 AH 10 60 SWF 19.1 ms © YBW 300 Hz 8 AH 10 50 SBA 10 SB SWF 19.1 ms © YBW 300 Hz 8 AH 10 SB SWF 19.1 ms © YBW 300 Hz 8 AH 10 SB SWF 19.1 ms © YBW 300 Hz 8 AH 10 SB SWF 19.1 ms © YBW 300 Hz 8 AH 10 SB SWF 19.1 ms © YBW 300 Hz 8 AH 10 SB SWF 19.1 ms © YBW 300 Hz 8 AH 10 SB SWF 19.1 ms © YBW 300 Hz 10 SB SWF 19.1 ms © YBW 300





# 7.5. Frequency Stability Measurement

### **7.5.1.** Test Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

### 7.5.2. Test Procedure Used

# Frequency Stability Under Temperature Variations:

The equipment under test was connected to an external AC or DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 20°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to highest. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C decreased per stage until the lowest temperature reached.

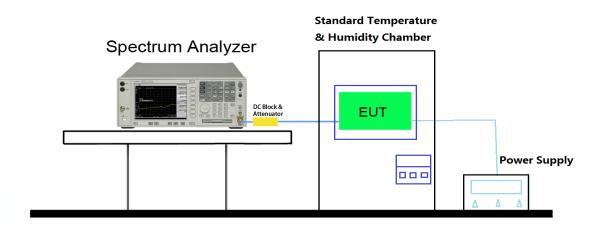
# Frequency Stability Under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation (±15%) and endpoint, record the maximum frequency change.



# 7.5.3. Test Setup





# 7.5.4. Test Result

Test Engineer	Fran	Temperature	-20 ~ 50°C
Test Time	2024/7/16	Relative Humidity	58%RH

	RFID 13.56MHz Frequency Stability									
			. Frequency Stabilit	•						
Voltage (%)	Power (VAC)	Temp (°C)	Frequency (MHz)	Frequency Tolerance (ppm)	Limit (ppm)					
		- 20	13.5613	95.87	±100					
		- 10	13.5613	95.87	±100					
		0	13.5613	95.87	±100					
4000/	120\//60   -	+ 10	13.5613	95.87	±100					
100%	120V/60Hz	+ 20 (Ref)	13.5613	95.87	±100					
		+ 30	13.5612	88.50	±100					
		+ 40	13.5612	88.50	±100					
		+ 50	13.5612	88.50	±100					
	Test Result			PASS						
		Voltage vs. F	requency Stability							
Voltage (%)	Power (VAC)	Temp (°C)	Frequency (MHz)	Frequency Tolerance (ppm)	Limit (ppm)					
100%	120V/60Hz	+ 20	13.5613	95.87	±100					
115%	138V/60Hz	+ 20	13.5612	88.50	±100					
85% 102V/60Hz + 2		+ 20	13.5612	88.50	±100					
	Test Result			PASS						

# Note:

Frequency Tolerance (ppm) =  $\{[Measured Frequency (Hz) - Declared Frequency (Hz)] / Declared Frequency (Hz)\} *10<sup>6</sup>.$ 



# 7.6. AC Conducted Emissions Measurement

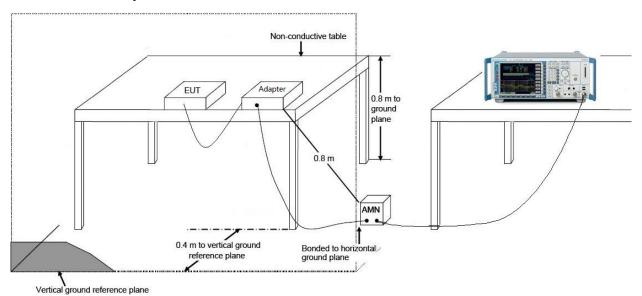
# 7.6.1. Test Limit

FCC Part 15 Subpart C Paragraph 15.207 Limits								
Frequency (MHz)	QP (dBuV)	AV (dBuV)						
0.15 - 0.50	66 - 56	56 - 46						
0.50 - 5.0	56	46						
5.0 - 30	60	50						

Note 1: The lower limit shall apply at the transition frequencies.

Note 2: The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz.

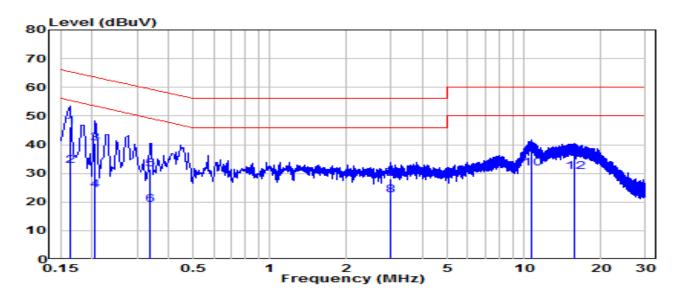
# 7.6.2. Test Setup





# 7.6.3. Test Result

EUT	Portable Analyzer	Date of Test	2024-07-12
Factor	CE_ENV216-L1 (Filter ON)	Temp. / Humidity	27.2°C /52%
Polarity	Line1	Site / Test Engineer	SR2 / Will
Test Mode	TX_RFID_13.56MHz	Test Voltage	AC 120V/60Hz

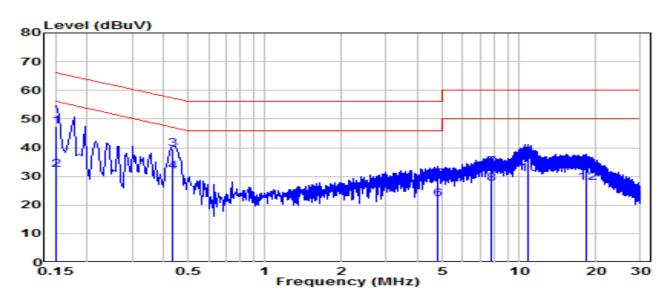


No		Frequency	Reading	C.F	Measurement	Margin	Limit	Remark
INO		(MHz)	(dBuV)	(dB)	(dBuV)	(dB)	(dBuV)	(QP/PK/AV)
1		0.163	36.43	9.63	46.06	-19.23	65.28	QP
2		0.163	22.97	9.63	32.60	-22.68	55.28	Average
3		0.204	30.80	9.63	40.43	-23.01	63.45	QP
4		0.204	14.59	9.63	24.22	-29.23	53.45	Average
5		0.339	21.83	9.64	31.47	-27.76	59.23	QP
6		0.339	9.40	9.64	19.04	-30.19	49.23	Average
7		2.989	18.42	9.71	28.13	-27.87	56.00	QP
8		2.989	12.49	9.71	22.21	-23.79	46.00	Average
9	*	10.746	27.38	9.87	37.26	-22.74	60.00	QP
10	*	10.746	21.79	9.87	31.66	-18.34	50.00	Average
11		15.799	26.05	9.91	35.96	-24.04	60.00	QP
12		15.799	20.69	9.91	30.60	-19.40	50.00	Average

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = LISN Factor (dB)+ Cable Loss (dB).
- 3. Measurement (dBuV) = Reading(dBuV) + C.F (Correction Factor).



EUT	Portable Analyzer	Date of Test	2024-07-12
Factor	CE_ENV216-N (Filter ON)	Temp. / Humidity	27.2°C /52%
Polarity	Neutral	Site / Test Engineer	SR2 / Will
Test Mode	TX_RFID_13.56MHz	Test Voltage	AC 120V/60Hz

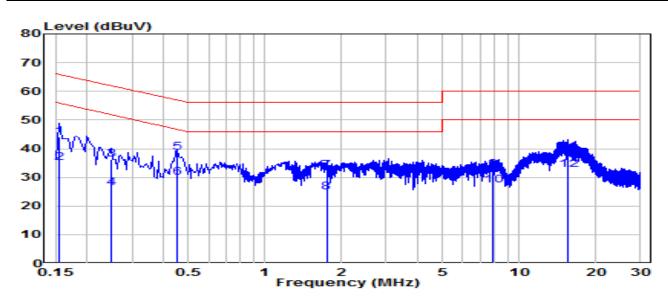


No		Frequency	Reading	C.F	Measurement	Margin	Limit	Remark
INO		(MHz)	(dBuV)	(dB)	(dBuV)	(dB)	(dBuV)	(QP/PK/AV)
1		0.150	37.71	9.63	47.34	-18.66	66.00	QP
2		0.150	22.66	9.63	32.29	-23.71	56.00	Average
3	*	0.433	29.79	9.65	39.44	-17.75	57.19	QP
4	*	0.433	22.17	9.65	31.82	-15.37	47.19	Average
5		4.789	19.33	9.75	29.08	-26.92	56.00	QP
6		4.789	12.38	9.75	5 22.14 -23.86		46.00	Average
7		7.804	23.40	9.83	33.23	-26.77	60.00	QP
8		7.804	17.59	9.83	27.42	-22.58	50.00	Average
9		10.827	26.77	9.90	36.67	-23.33	60.00	QP
10		10.827	20.98	9.90	30.88	-19.12	50.00	Average
11		18.283	22.99	9.98	32.97	-27.03	60.00	QP
12		18.283	17.84	9.98	27.82	-22.18	50.00	Average

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = LISN Factor (dB)+ Cable Loss (dB).
- 3. Measurement (dBuV) = Reading(dBuV) + C.F (Correction Factor).



EUT	Portable Analyzer	Date of Test	2024-07-12
Factor	CE_ENV216-L1 (Filter ON)	Temp. / Humidity	27.2°C /52%
Polarity	Line1	Site / Test Engineer	SR2 / Will
Test Mode	TX_RFID_13.56MHz	Test Voltage	AC 240V/60Hz

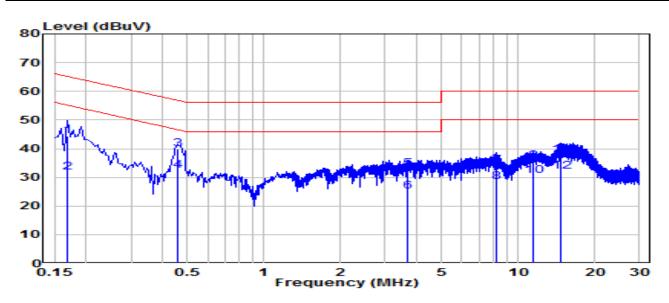


NIa	Frequency Reading C.F		Measurement	Margin	Limit	Remark	
No	(MHz)	(dBuV)	(dB)	(dBuV)	(dB)	(dBuV)	(QP/PK/AV)
1	0.154	34.58	9.63	44.21	-21.54	65.75	QP
2	0.154	25.48	9.63	35.11	-20.64	55.75	Average
3	0.249	26.47	9.64	36.11	-25.68	61.79	QP
4	0.249	16.73	9.64	26.37	-25.42	51.79	Average
5 *	* 0.451	29.13	9.65	38.78	-18.07	56.85	QP
6 *	* 0.451	20.15	9.65	29.80	-17.05	46.85	Average
7	1.747	22.73	9.69	32.43	-23.57	56.00	QP
8	1.747	14.93	9.69	24.63	-21.37	46.00	Average
9	7.871	22.83	9.82	32.64	-27.36	60.00	QP
10	7.871	17.38	9.82	27.19	-22.81	50.00	Average
11	15.511	28.72	9.90	38.62	-21.38	60.00	QP
12	15.511	22.68	9.90	32.59	-17.41	50.00	Average

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = LISN Factor (dB)+ Cable Loss (dB).
- 3. Measurement (dBuV) = Reading(dBuV) + C.F (Correction Factor).



EUT	Portable Analyzer	Date of Test	2024-07-12
Factor	CE_ENV216-N (Filter ON)	Temp. / Humidity	27.2°C /52%
Polarity	Neutral	Site / Test Engineer	SR2 / Will
Test Mode	TX_RFID_13.56MHz	Test Voltage	AC 240V/60Hz



No		Frequency	Reading	C.F	Measurement	Margin	Limit	Remark
No		(MHz)	(dBuV)	(dB)	(dBuV)	(dB)	(dBuV)	(QP/PK/AV)
1		0.168	34.76	9.63	44.39	-20.67	65.06	QP
2		0.168	22.09	9.63	31.72	-23.33	55.06	Average
3	*	0.456	30.16	9.65	39.81	-16.96	56.77	QP
4	*	0.456	22.58	9.65	32.23	-14.54	46.77	Average
5		3.696	23.11	9.74	32.85	-23.15	56.00	QP
6		3.696	15.25	9.74	24.99	-21.01	46.00	Average
7		8.249	24.40	9.84	34.24	-25.76	60.00	QP
8		8.249	18.54	9.84	28.39	-21.61	50.00	Average
9		11.475	25.73	9.90	35.63	-24.37	60.00	QP
10		11.475	20.49	9.90	30.39	-19.61	50.00	Average
11		14.711	27.87	9.94	37.80	-22.20	60.00	QP
12		14.711	21.92	9.94	31.86	-18.14	50.00	Average

- 1. " \*", means this data is the worst emission level.
- 2. C.F (Correction Factor) = LISN Factor (dB)+ Cable Loss (dB).
- 3. Measurement (dBuV) = Reading(dBuV) + C.F (Correction Factor).



# 8. CONCLUSION

The data collected relate only the item(s) tested and show that the **Portable Analyzer** is in compliance with Part 15.225 of the FCC Rules.

Page Number: 39 of 40



# **Appendix A : Test Photograph**

Refer to "2406TW3801-UT" file.

A	p	pei	nd	ix	В	:	<b>External</b>	F	Phot	0	qı	rai	ρl	h
	-		_							_	_		-	

Refer to "2406TW3801-UE" file.

<b>Appendix</b>	C	:	Internal	F	Photo	qrai	ph
-----------------	---	---	----------	---	-------	------	----

Refer to "2406TW3801-UI" file.		
	The End	